



SLP830S / SLF830S

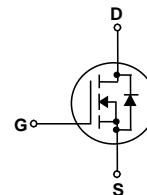
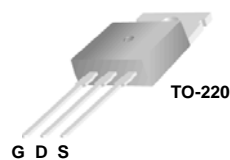
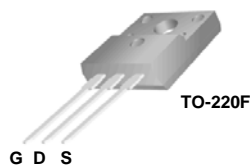
SLP830S / SLF830S 500V N-Channel MOSFET

General Description

This Power MOSFET is produced using Maple semi's advanced planar stripe DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.

Features

- 5.0A, 500V, $R_{DS(on)} = 1.35\Omega @ V_{GS} = 10V$
- Low gate charge (typical 26nC)
- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter	SLF830S	SLP830S	Units
V _{DSS}	Drain-Source Voltage	500		V
I _D	Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 100°C)	5.0		A
		3.0		A
I _{DM}	Drain Current - Pulsed (Note 1)	20		A
V _{GSS}	Gate-Source Voltage	±30		V
EAS	Single Pulsed Avalanche Energy (Note 2)	280		mJ
I _{AR}	Avalanche Current (Note 1)	5.0		A
E _{AR}	Repetitive Avalanche Energy (Note 1)	--		mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	5.5		V/ns
P _D	Power Dissipation (T _C = 25°C)	48	74	W
T _J , T _{STG}	Operating and Storage Temperature Range	-55 to +150		°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300		°C

Thermal Characteristics

Symbol	Parameter	Max.		Units
		SLF830S	SLP830S	
R _{θJC}	Thermal Resistance, Junction-to-Case	2.60	1.69	°C/W
R _{θJS}	Thermal Resistance, Case-to-Sink Typ.	62.5	62.5	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient	110	110	°C/W

Electrical CharacteristicsT_C = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA	500	--	--	V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25 °C	--	0.61	--	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 500 V, V _{GS} = 0 V	--	--	25	μA
		V _{DS} = 400 V, T _C = 125 °C	--	--	250	μA
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V	--	--	100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{DS} = 0 V	--	--	-100	nA
On Characteristics						
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250 μA	2.0	--	4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 2.0 A	--	1.35	1.5	Ω
g _{FS}	Forward Transconductance	V _{DS} = 40 V, I _D = 2.0 A (Note 4)	2.4	--	--	S
Dynamic Characteristics						
C _{iss}	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz	--	560	--	pF
C _{oss}	Output Capacitance		--	45	--	pF
C _{rss}	Reverse Transfer Capacitance		--	17	--	pF
Switching Characteristics						
t _{d(on)}	Turn-On Delay Time	V _{DD} = 250 V, I _D = 5.0 A, R _G = 25 Ω (Note 4, 5)	--	--	--	ns
t _r	Turn-On Rise Time		--	--	--	ns
t _{d(off)}	Turn-Off Delay Time		--	20	--	ns
t _f	Turn-Off Fall Time		--	--	--	ns
Q _g	Total Gate Charge	V _{DS} = 480 V, I _D = 4.0A, V _{GS} = 10 V (Note 4, 5)	--	13.3	--	nC
Q _{gs}	Gate-Source Charge		--	4.0	--	nC
Q _{gd}	Gate-Drain Charge		--	15	--	nC
Drain-Source Diode Characteristics and Maximum Ratings						
I _S	Maximum Continuous Drain-Source Diode Forward Current		--	--	5.0	A
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		--	--	20	A
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 4.0 A	--	--	1.6	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 4.0 A,	--	220	--	ns
Q _{rr}	Reverse Recovery Charge	dI _F / dt = 100 A/us (Note 4)	--	1.0	--	μC

Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. I_{AS} = 5.0A, L=24mH, V_{DD} = 50V, R_G = 25Ω, Starting T_J = 25°C
3. I_{SD} ≤ 5.0A, di/dt ≤ 200A/us, V_{DD} ≤ BV_{DSS}, Starting T_J = 25°C
4. Pulse Test : Pulse width ≤ 300us, Duty cycle ≤ 2%
5. Essentially independent of operating temperature

Typical Characteristics

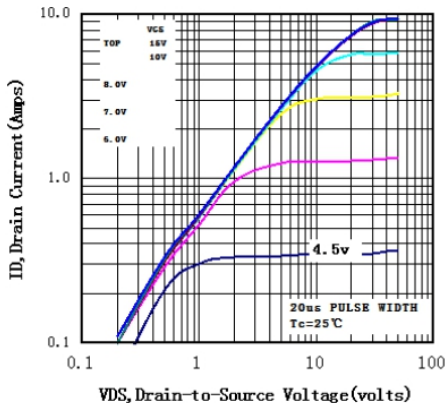


Figure 1. Typical Output Characteristics
Tc=25°C

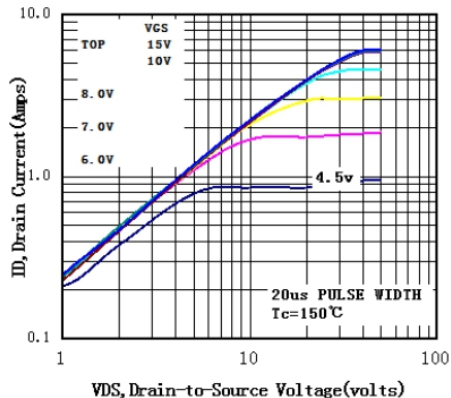


Figure 2. Typical Output Characteristics
Tc=150°C

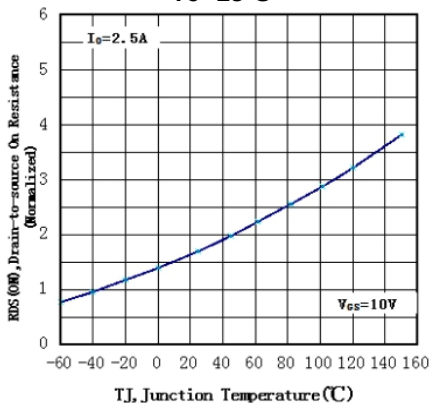


Figure 3. Normalized Resistance VS
Temperature

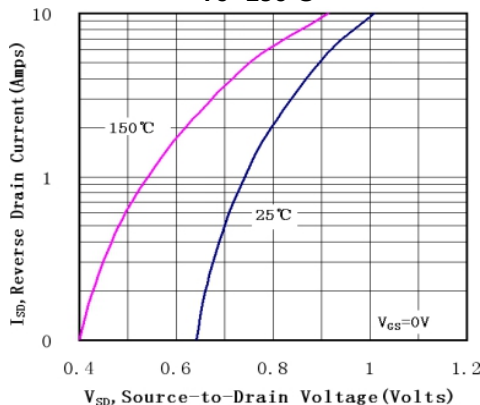


Figure 4. Typical Source-Drain Diode
Forward Voltage

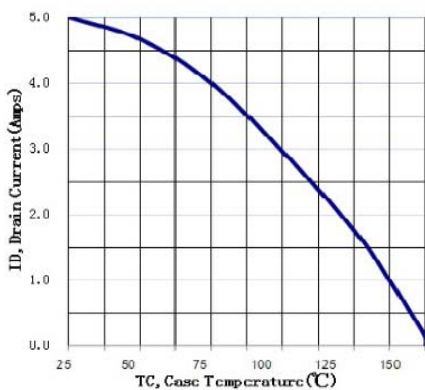


Figure 5. Maximum Current VS
Case Temperature

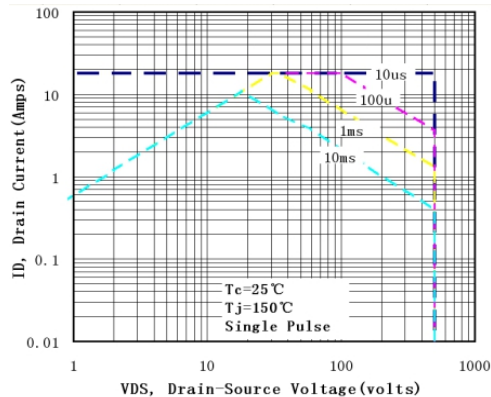
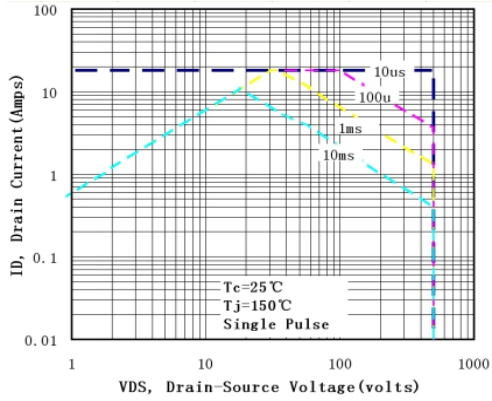


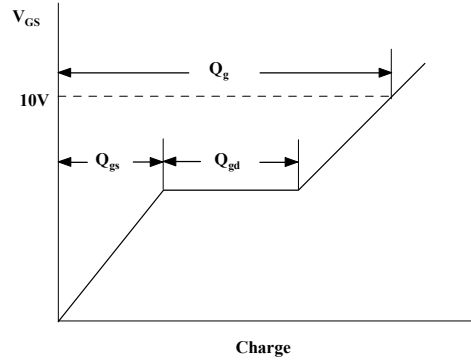
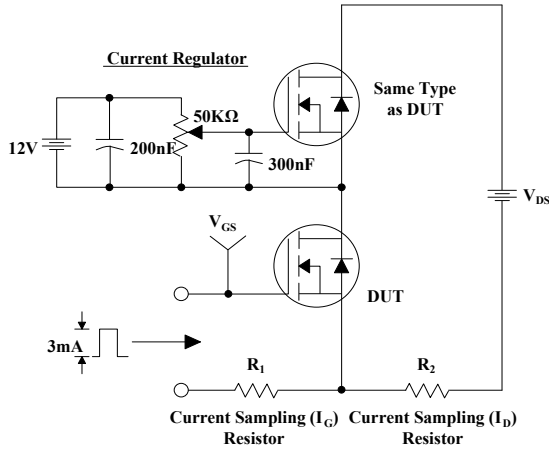
Figure 6-1. Maximum Safe Operating Area
TO-220F

Typical Characteristics (Continued)

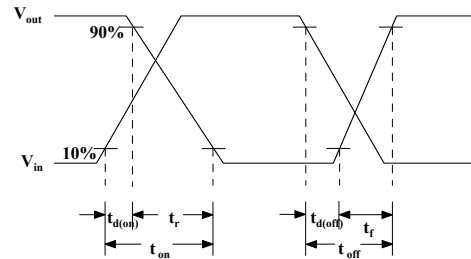
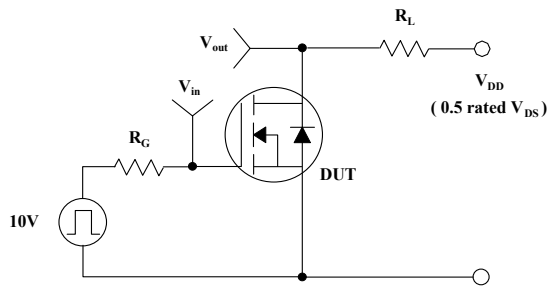


**Figure 6-2. Maximum Safe Operating Area
TO-220**

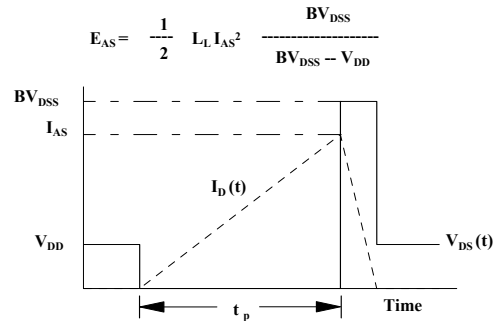
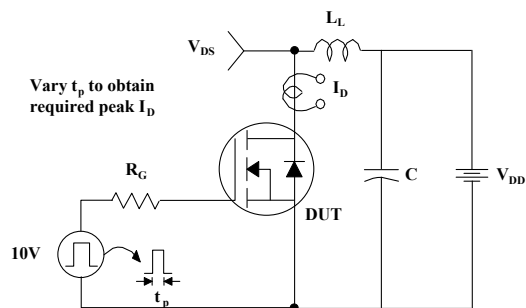
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms



Peak Diode Recovery dv/dt Test Circuit & Waveforms

